

Notice of References Cited	Application/Control No. 10/534,064		Applicant(s)/Patent Under Reexamination KALLISKE ET AL.	
	Examiner Karen J. Amores		Art Unit 3616	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,182,782 B1	02-2001	Matsuura et al.	180/274
*	B	US-2002/0060447 A1	05-2002	Acker et al.	280/730.1
*	C	US-2003/0001366 A1	01-2003	Debler et al.	280/732
*	D	US-6,668,962 B2	12-2003	Son, Byeong-Lag	180/274
*	E	US-2004/0080146 A1	04-2004	Lutz et al.	280/736
*	F	US-2004/0195810 A1	10-2004	Dietze et al.	280/732
*	G	US-6,857,495 B2	02-2005	Sawa, Tomohiro	180/274
*	H	US-6,883,557 B1	04-2005	Eschbach et al.	139/387R
*	I	US-6,938,715 B2	09-2005	Hamada et al.	180/274
*	J	US-2005/0248184 A1	11-2005	Piffaretti, Marco	296/187.03
*	K	US-2007/0075532 A1	04-2007	Yokoyama et al.	280/730.2
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.